

Notice of References Cited	Application/Control No. 10/694,420	Applicant(s)/Patent Under Reexamination HAYNES ET AL.	
	Examiner Sang W. An	Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,365,088 B1	04-2002	Knight et al.	264/436
	B	US-			
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO02052071A2	07-2002	International	Haynes, Brian, David	D01D 5/098
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NON-PATENT DOCUMENTS

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